Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/650,881	FU ET AL.	
Examiner	Art Unit	
Paul D. Kim	3720	

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Class	Subclass	Date	Examiner
29	603.03- 603.06	7/5/2005	РК
360	98.07 99.04	_	
	97.01-97.04	+	
	99.05-99.12	V	
310	51,67R,91	7/5/2005	PK

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Reviewed 10/651,066 10/462,339	7/5/2005	PK		
Text Search EAST/NPL (IEEE)	7/6/2005	PK		
PGPub Text Search	10/29/2005	PK		
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